



P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{DSS}	R _{DS(ON)} MAX	Package	I _D T _A = +25°C
-30V	$70m\Omega @V_{GS} = -10V$	SO-8	-3.9A
-307	$95mΩ @V_{GS} = -4.5V$	30-6	-3.3A

Description

This MOSFET has been designed to minimize the on-state resistance $(R_{DS(ON)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Backlighting
- Power Management Functions
- DC-DC Converters

Features

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Mechanical Data

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0

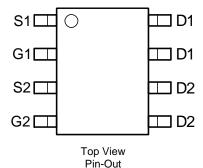
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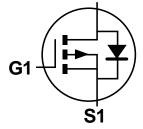
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Lead Frame. Solderable per MIL-STD-202, Method 208 (€3)
- Weight: 0.074 grams (Approximate)

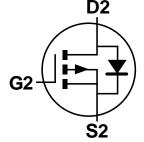
SO-8



Top View







Equivalent Circuit

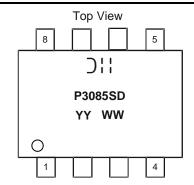
Ordering Information (Note 4)

Part Number	Case	Packaging
DMP3085LSD-13	SO-8	2500/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/

Marking Information



);; = Manufacturer's Code Marking P3085SD = Product Type Marking Code YYWW = Date Code Marking YY or YY = Year (ex: 19 = 2019) WW = Week (01 to 53)



Maximum Ratings $(@T_A = +25^{\circ}C, \text{ unless otherwise specified.})$

Characteristic	Symbol	Value	Unit		
Drain-Source Voltage	V_{DSS}	-30	V		
Gate-Source Voltage	V_{GSS}	±20	V		
Continuous Prain Correct (Note C) // 40)/	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	-3.9 -3.1	А
Continuous Drain Current (Note 6) V _{GS} = -10V	t<10s	$T_A = +25$ °C $T_A = +70$ °C	I _D	-4.9 -3.9	А
Maximum Continuous Body Diode Forward Current	Is	-2.5	Α		
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%	I _{DM}	-20	Α		

Thermal Characteristics

Characteristic	Symbol	Value	Unit		
Total Power Dissipation (Note 5)	$T_A = +25^{\circ}C$	Pn	1.1	W	
Total Power Dissipation (Note 5)	$T_A = +70^{\circ}C$	PD	0.7		
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	R _{0,JA}	107	°C/W	
Thermal Resistance, Junction to Ambient (Note 3)	t<10s	KθJA	70	C/VV	
Total Power Dissipation (Note 6)	$T_A = +25$ °C	D-	1.7	W	
Total Fower Dissipation (Note o)	$T_A = +70^{\circ}C$	P_{D}	1.1	V V	
Thermal Resistance, Junction to Ambient (Note 6)	Steady State	D	75		
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{\theta JA}$	50	°C/W	
Thermal Resistance, Junction to Case	$R_{ heta JC}$	14.5			
Operating and Storage Temperature Range	$T_{J_{I}}T_{STG}$	-55 to +150	°C		

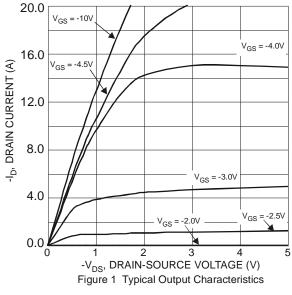
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

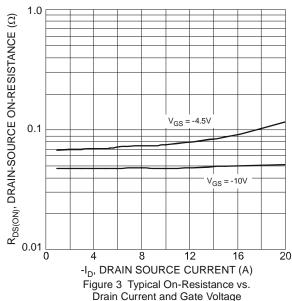
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV _{DSS}	-30		_	V	$V_{GS} = 0V, I_{D} = -250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	_	_	-1	μA	$V_{DS} = -30V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V _{GS(TH)}	-1	_	-3	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
Static Drain-Source On-Resistance		1	50	70	mΩ	$V_{GS} = -10V, I_D = -5.3A$	
Static Dialit-Source Off-Nesistance	R _{DS(ON)}		75	95	mu	$V_{GS} = -4.5V$, $I_D = -4.2A$	
Forward Transfer Admittance	Y _{fs}	_	5.8	_	S	$V_{DS} = -5V$, $I_{D} = -5.3A$	
Diode Forward Voltage	V_{SD}	_	-0.7	-1.2	V	$V_{GS} = 0V, I_{S} = -1A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	Ciss		563	_		V _{DS} = -25V, V _{GS} = 0V, f = 1.0MHz	
Output Capacitance	Coss	_	48	_	pF		
Reverse Transfer Capacitance	C _{rss}	_	41	_			
Gate Resistance	R_G	_	10.3	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge (V _{GS} = -4.5V)	Q_g	_	5.2	_			
Total Gate Charge (V _{GS} = -10V)	Qg	_	11	_	nC	$V_{DS} = -15V$, $I_{D} = -3.8A$	
Gate-Source Charge	Q_{gs}	_	1.7	_	IIC		
Gate-Drain Charge	Q_{gd}	_	1.9	_			
Turn-On Delay Time	t _{D(ON)}	_	4.8	_	_	V _{DS} = -15V, V _{GS} = -10V,	
Turn-On Rise Time	t _R	ı	5	_	ns		
Turn-Off Delay Time	t _{D(OFF)}	1	31	_	115	$I_D = -1A, R_G = 6.0\Omega$	
Turn-Off Fall Time	t _F	_	14.6	_			

Notes:

- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
- 7. Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to product testing.







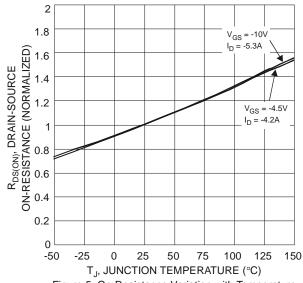
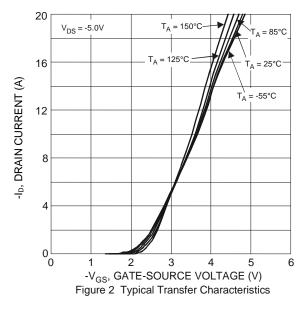
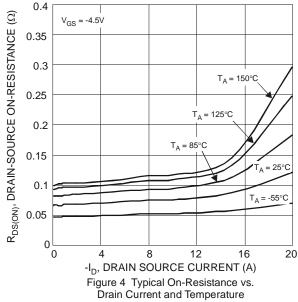


Figure 5 On-Resistance Variation with Temperature





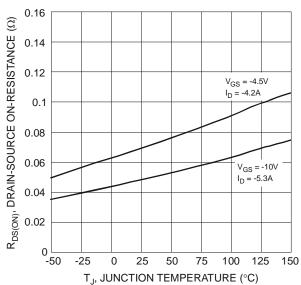


Figure 6 On-Resistance Variation with Temperature



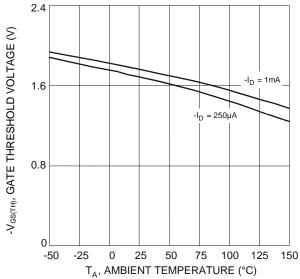
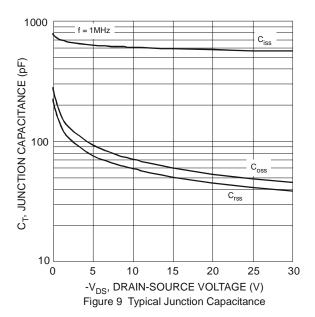
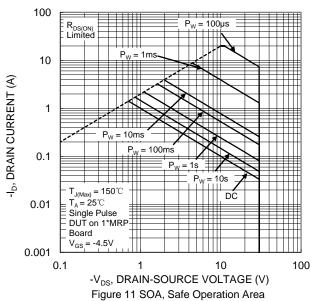
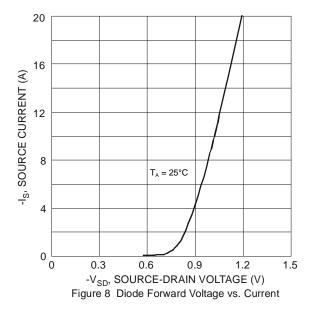
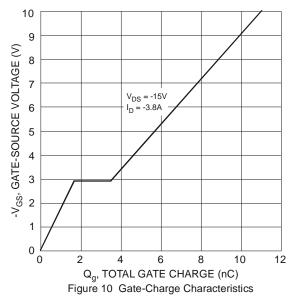


Figure 7 Gate Threshold Variation vs. Ambient Temperature









July 2019

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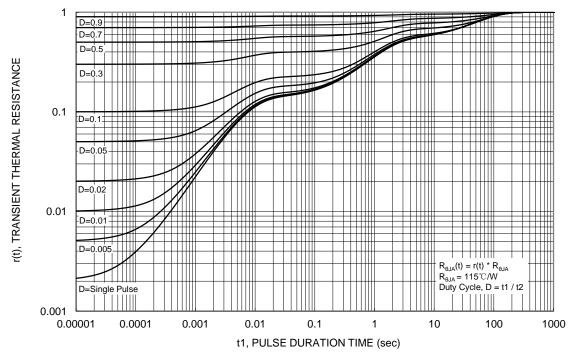


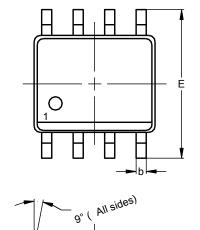
Figure 12 Transient Thermal Resistance

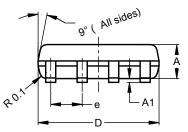


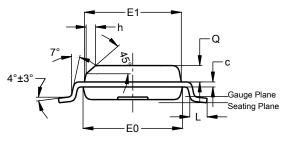
Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

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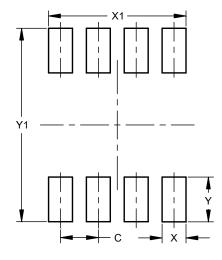


SO-8					
Dim	Min	Max	Тур		
Α	1.40	1.50	1.45		
A1	0.10	0.20	0.15		
b	0.30	0.50	0.40		
С	0.15	0.25	0.20		
D	4.85	4.95	4.90		
Е	5.90	6.10	6.00		
E1	3.80	3.90	3.85		
E0	3.85	3.95	3.90		
е			1.27		
h			0.35		
L	0.62	0.82	0.72		
Q	0.60	0.70	0.65		
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

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Dimensions	Value (in mm)			
С	1.27			
Х	0.802			
X1	4.612			
Υ	1.505			
Y1	6.50			



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